



Implementation of B.I.S.T Technique in an Aes for a Cryptocore

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ABSTRACT:

The main motive of this project is to design a crypto device with low complexity and high security by using “ADVANCED ES” Algorithm along with BIST technique. The selective application of technological and related procedural safeguards is an important responsibility of every Federal organization in providing adequate security to its electronic data systems and coming to BIST concept there are two main functions that must be performed on-chip in order to implement built-in self-test (BIST): test pattern generation and output response analysis. The most common BIST schemes are based on pseudorandom test pattern generation using linear feedback shift registers (LFSR’S) and output response compaction using signature analyzers. To accomplish high security for a system we are using the crypto devices technique in our project.

INTRODUCTION:

Most of the user now a day’s using wireless communication for fast sending and receiving the mails in less time and in less cost. When this way of communication is going on, the unauthorized people who have the intension to know about our conversation will hack the information within that frequency. After hacking the information the hacker can know about what we are discussing. This leads to leakage of information. Nowadays, secure circuits are commonly used for applications such as e-banking, pay tv, cell phone... Because they hold personal data and must process secure

operations, security requirements such as source/sink authentication, data integrity, confidentiality, or tamper resistance are maintained by means of several dedicated components. Confidentiality is ensured through cryptographic mechanisms generally implemented on co-processors.

PROPOSED MODEL:

The AES algorithm is capable of using cryptographic keys of 128, 192, and 256 bits to encrypt and decrypt data in blocks of 128 bits. Rijndael was designed to handle additional block sizes and key lengths; however they are not adopted in this standard. Throughout the remainder of this standard, the algorithm specified here in will be referred to as “the AES algorithm.” The algorithm may be used with the three different key lengths indicated above, and therefore these different “flavours” may be referred to as “AES-128”, “AES-192”, and “AES-256”.

This specification includes the following sections:

1. Definitions of terms, acronyms, and algorithm parameters, symbols, and functions.
2. Notation and conventions used in the algorithm specification, including the ordering and numbering of bits, bytes, and words.
3. Mathematical properties that is useful in understanding the algorithm.

4. Algorithm specification, covering the key expansion, encryption, and decryption routines.
5. Implementation issues, such as key length support, keying restrictions, and additional block/key/round sizes.

The standard concludes with several appendices that include step-by-step examples for Key. At the start of the Cipher, the input is copied to the State array using the conventions. After an initial Round Key addition, the State array is transformed by implementing a round function 10, 12, or 14 times (depending on the key length), with the final round differing slightly from the first $N_r - 1$ rounds. The final State is then copied to the output.

The round function is parameterized using a key schedule that consists of a one-dimensional array of four-byte words derived using the Key Expansion routine.

The Cipher is described in the pseudo code. The individual transformations - Sub Bytes (), Shift Rows (), Mix Columns (), and AddRoundKey () – process the State and are described in the following subsections...

It is very important to know that the cipher input bytes are mapped onto the state bytes in the order $a_{0,0}, a_{1,0}, a_{2,0}, a_{3,0}, a_{0,1}, a_{1,1}, a_{2,1}, a_{3,1} \dots$ and the bytes of the cipher key are mapped onto the array in the order $k_{0,0}, k_{1,0}, k_{2,0}, k_{3,0}, k_{0,1}, k_{1,1}, k_{2,1}, k_{3,1} \dots$ At the end of the cipher operation, the cipher output is extracted from the state by taking the state bytes in the same order. AES uses a variable number of rounds, which are fixed: A key of size 128 has 10 rounds. A key of size 192 has 12 rounds. A key of size 256 has 14 rounds.

During each round, the following operations are applied on the state:

1. Sub Bytes: every byte in the state is replaced by another one, using the Rijndael S-Box
2. Shift Row: every row in the 4x4 array is shifted a certain amount to the left
3. Mix Column: a linear transformation on the columns of the state.
4. AddRoundKey: each byte of the state is combined with a round key, which is a different key for each round and derived from the Rijndael key schedule.

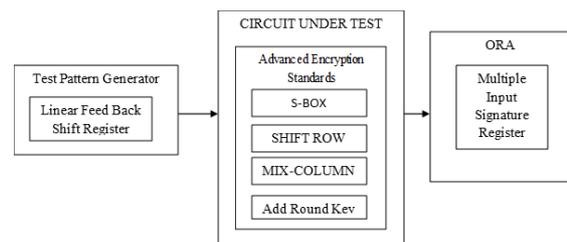


Fig: Self-Test Technique for Crypto Devices

overall architecture of LBIST with AES. Starting block linear feedback shift register is used for Test pattern Generator. In computing, a linear-feedback shift register (LFSR) is a shift register whose input bit is a linear function of its previous state. The most commonly used linear function of single bits is exclusive-or (XOR). Thus, an LFSR is most often a shift register whose input bit is driven by the XOR of some bits of the overall shift register value. It is used to generate all type of test patterns for Circuit under Test. Here, in this concept 128 bit LFSR is used as test pattern generator. $2^{128} - 1$ patterns are generated by using above LFSR. Since, XOR gate is used to construct LFSR, all zeros combination is can't be generated.

Output Response Analyzer is last and vital device. Final output checking is done by this component. If any error occurred in whole process or not is checked by this ORA. ORA takes input from AES practical circuit and theoretical circuit, it compares both inputs using XOR gates, yields final output. 128 xor gates are used to compare produced outputs.

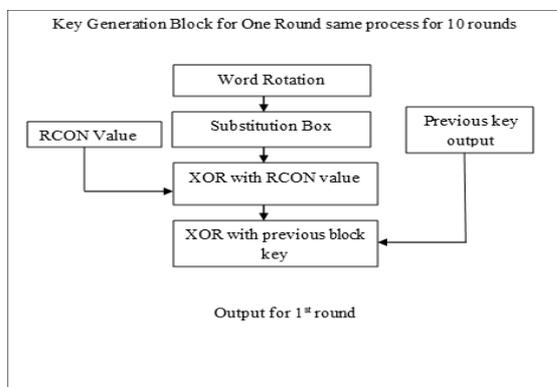


Fig : Key Generation Diagram

Symmetric-key algorithms use a single shared key; keeping data secret requires

keeping this key secret. Public-key algorithms use a public key and a private key. The public key is made available to anyone (often by means of a digital certificate). A sender encrypts data with the public key; only the holder of the private key can decrypt this data. Since public-key algorithms tend to be much slower than symmetric-key algorithms, modern systems such as TLS and SSH use a combination of the two: one party receives the other's public key, and encrypts a small piece of data (either a symmetric key or some data used to generate it). The remainder of the conversation uses a (typically faster) symmetric-key algorithm for encryption. Computer cryptography uses integers for keys. In some cases keys are randomly generated using a random number generator (RNG) or pseudorandom number generator (PRNG). A PRNG is a computer algorithm that produces data that appears random under analysis.

PRNGs that use system entropy to seed data generally produce better results, since this makes the initial conditions of the PRNG much more difficult for an attacker to guess. In other situations, the key is derived deterministically using a passphrase and a key derivation function. The simplest method to read encrypted data is a brute force attack—simply attempting every number, up to the maximum length of the key. Therefore, it is important to use a sufficiently long key length; longer keys take exponentially longer to attack, rendering a brute force attack impractical. Currently, key lengths of 128 bits (for symmetric key algorithms) and 1024

bits (for public-key algorithms) are common.

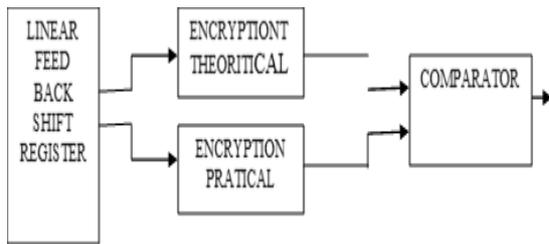


Fig : Self- Test for Encryption Side Diagram

A built in self test or built in test is a mechanism that permits a machine to test itself. We design BISTs to meet the requirements such as:

The main purpose of BIST is to reduce complexity of test/probe setup, by reducing the number of I/O signals that must be drives/Examined under tetser control, reduce the size. Both lead to reduce in hourly charges for automated test equipment(ATE) service. Similar to encryption, decryption block diagram looks similar only change is instead of encryption we use decryption.

LFSR PESUDORANDOM TEST GENERATION: To develop a battery of statistical tests to detect non randomness in binary m sequences constructed using random number generators and pseudorandom no generators utilized in cryptographic applications, To produce documentation and software implementation of these tests, and To provide guidance in the use and application of these tests. Pseudorandom- generate patterns that appear to be random but are in fact deterministic (repeatable).Linear Feedback Shift Register (LFSR) Weighted pseudo-random test generation Adaptive pseudo-random test

generation

Algorithmic Test Generation: List primary inputs controlling location where a fault should be detected.

Determine primary input conditions to activate a fault and to sensitize the primary outputs such that the fault can be observed.

Pseudo-Random Test Generation

- Large set of patterns is generated by simple HW or SW pseudo-random generator
- The set is used to stimulate a system with fault simulator
- Fault coverage is analyzed and algorithmic approach is used to cover remain faults.

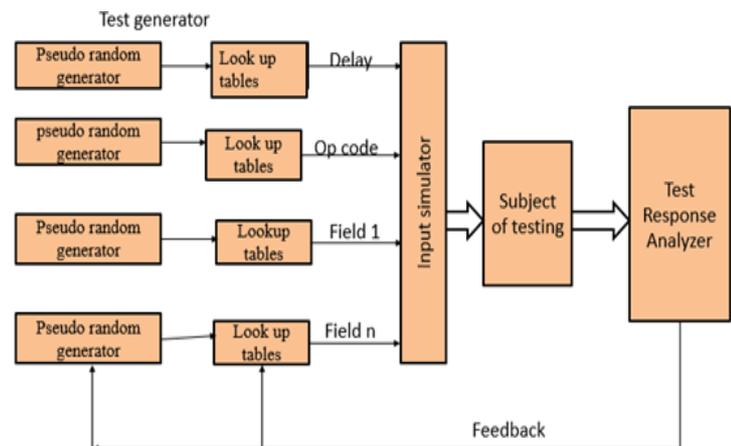


Fig : Complex Pseudo-Random test generator

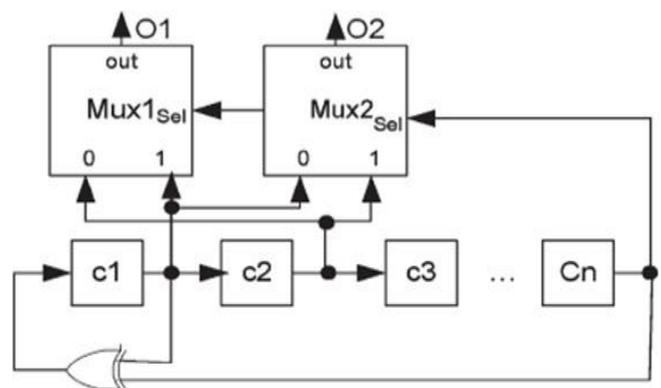


Fig: Bitswapping LFSR

added to the current mission of the AES crypto core. One for pseudo- random test pattern generation & one for signature analysis. Efficiency of these three modes has been demonstrated. Extra cost in terms of area is very low compared to other techniques. Because only one AES core will be originally embedded in the system. This reduces the reduction of test cost will lead to the reduction of overall production cost & 100% security of data.

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